

Notice of References Cited	Application/Control No. 10/772,128	Applicant(s)/Patent Under Reexamination SEYER ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,192,329 A	03-1993	Christie et al.	623/22.22
*	B	US-5,314,487 A	05-1994	Schryver et al.	623/22.37
*	C	US-5,358,532 A	10-1994	Evans et al.	623/22.23
*	D	US-5,507,825 A	04-1996	Frei, Heribert	623/22.36
*	E	US-5,549,691 A	08-1996	Harwin, Steven F.	623/22.37
*	F	US-5,702,473 A	12-1997	Albrektsson et al.	623/22.31
*	G	US-6,152,961 A	11-2000	Ostiguy et al.	623/22.28
*	H	US-6,162,256 A	12-2000	Ostiguy et al.	623/22.26
*	I	US-6,168,600 B1	01-2001	Grace et al.	606/81
*	J	US-6,281,264 B1	08-2001	Salovey et al.	523/115
*	K	US-2001/0051830 A1	12-2001	TUKE et al.	623/22.12
*	L	US-2002/0040245 A1	04-2002	Lester et al.	623/22.23
*	M	US-6,451,058 B2	09-2002	Tuke et al.	623/22.21

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
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NON-PATENT DOCUMENTS

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	Examiner Ann Schillinger	Art Unit 3738	Page of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,903,549 A	09-1975	Deyerle, William Minor	623/22.36
*	B	US-4,023,572 A	05-1977	Weigand et al.	606/81
*	C	US-4,883,491 A	11-1989	Mallory et al.	623/22.31
*	D	US-5,021,062 A	06-1991	Adrey et al.	623/22.36
*	E	US-5,108,447 A	04-1992	Zeiler et al.	623/22.14
*	F	US-5,190,550 A	03-1993	Miller et al.	606/85
*	G	US-5,658,294 A	08-1997	Sederholm, Gary W.	606/91
*	H	US-5,732,992 A	03-1998	Mauldin, Cary M.	294/119.1
*	I	US-5,928,287 A	07-1999	Keller, Arnold	623/22.21
*	J	US-5,951,605 A	09-1999	Dennis et al.	623/13.11
*	K	US-6,063,124 A	05-2000	Amstutz, Harlan C.	623/22.21
*	L	US-6,238,435 B1	05-2001	Meulink et al.	623/22.12
*	M	US-6,228,121 B1	05-2001	Khalili, Farid Bruce	623/22.36

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-RE28,895 E	07-1976	Noiles, Douglas G.	623/22.31
*	B	US-5,098,437 A	03-1992	Kashuba et al.	606/89
*	C	US-5,417,696 A	05-1995	Kashuba et al.	606/91
*	D	US-5,571,200 A	11-1996	Cohen et al.	623/22.12
*	E	US-5,885,299 A	03-1999	Winslow et al.	606/99
*	F	US-5,938,701 A	08-1999	Hiernard et al.	606/99
*	G	US-6,022,357 A	02-2000	Reu et al.	606/99
*	H	US-6,132,469 A	10-2000	Schroeder, David W.	623/22.24
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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